| BEAMLINE | SCIENTIFIC TOPIC | ENERGY RANGE keV | BEAM SIZE H x V | NOMINAL FLUX ph/sec | DETECTORS | SAMPLE ENVIRONMENT & Beamline Support Labs | TECHNIQUE |
|--|---|------------------------|---|---|---|--|--------------|
| BM31 SNBL-II (Swiss- | Chemistry | | EXAFS Unfocused 4.7 - 80 DIFFRACTION 100 x 300 µm² PDF at 40 and 50 keV | EXAFS 10 ¹⁰ DIFFRACTION (focused) 10 ¹² at 40 keV | EXAFS Ion chambers for transmission measurements Canberra 13 element Ge-SSD and a "Vortex" silicon drift detector for fluorescence DIFFRACTION Fast measurements: Dexela 2923M 6 Si-analyzer channels High Res powder diffractometer | Hot air gas blower L-N2 cryostreamer, 4.5 K He flow cryostat RGA-Mass-spec & Massflow meters, back pressure controllers and gas switching rack Battery cells and sample changers holding 12 cells for RT measurements, 6 cells for T ≤ 200 °C | Diffraction |
| Norwegian Beamlines) SCIENTIST IN CHARGE Hermann Emerich ermano@esrf.fr | Cultural Heritage Environmental Sciences & | 4.7 - 80 | | | | | Scattering |
| | Geosciences Materials processing | | | | | | Spectroscopy |